

Search Notes



Application/Control No.

10/675,233

Examiner:

José V. Chen

Applicant(s)/Patent under Reexamination

WHITTED, WILLIAM H.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
108	143	12/6/05	DL
	137		
	5		
312	322		
	327		
	313		
108	8		
SEARCHED 7/24/06 DL			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
For q Back CIP Pen	12/6/05	DL
for MCT		
SEARCH IN 312		
Pal Hanson		
SEARCHED 7/24/06 DL		